

<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>			ATTY. DOCKET NO. <b>061282-0055</b>	SERIAL NO. <b>10/757,388</b>
			APPLICANT <b>Takeshi KOBAYASHI, et al.</b>	
(Substitute for form 1449/PTO)			FILING DATE <b>January 15, 2004</b>	GROUP <b>2814</b>
<b>U.S. PATENT DOCUMENTS</b>				
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code(s) (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
US				
<b>FOREIGN PATENT DOCUMENTS</b>				
EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Code - Number + -Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document Pages, Columns, Lines Where Relevant Figures Appear Translation Yes No
/D.N./		JP 2000-294690	10-20-2000	SHINKO ELECTRIC IND CO LTD; FUJITSU LTD JAPAN (w/English Abstract)
/D.N./		JP 2001-368254	12-26-2001	SHINKO ELECTRIC IND CO LTD JAPAN (w/English Abstract)
/D.N./		WO 95/26047	09-28-1995	HITACHI CHEMICAL COMPANY, LTD JAPAN (w/English Abstract)
<b>OTHER ART</b> (Including Author, Title, Date, Pertinent Pages, Etc.)				
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.		
/D.N./		Japanese Office Action with English translation, Issued in Japanese Patent Application No. 2005-071274 dated July 2, 2008.		
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